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Application/Control No.	Applicant(s)/Patent under Reexamination
10/564,249	MIYAWAKI ET AL.
Examiner	Art Unit
Megann E. Vaughn	2859

SEARCHED				
Class	Subclass	Date	Examiner	
324	320	7/22/2007	MV	
324	307	7/22/2007	MV	
			:	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
see attached EAST Search History	- 7/22/2007	. MV
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